



TEST / CALIBRATION REPORT

EMC / EMI Test Report for MECO Frequency Transducer

Testing as per BS EN 61326 (Edition 1998)



ELECTRONICS REGIONAL TEST LABORATORY (WEST)
MINISTRY OF COMMUNICATIONS & INFORMATION TECHNOLOGY, (STQC Dte.)

Government of India

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MEMORANDUM

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3. The result reported in this report are valid only at the time of and under the stated conditions of the measurements.

ELECTRONICS REGIONAL TEST LABORATORY (WEST)		REPORT NO.	
MINISTRY OF COMMUNICATIONS AND INFORMATION TECHNOLOGY (STQC DTE)		ERTL(W)/ 2003EMI 263	
SUBJECT: EMC TESTING OF FREQUENCY TRANSDUCER		DATE	PAGE
		17 SEP 2003	1
			OF 9

1. SCOPE

1.1 Service Request No :ERTL(W)/20031658

1.1.1 Service Request finalised on :01- SEP - 2003

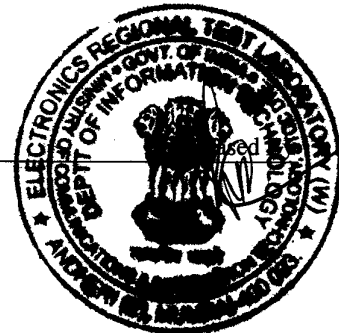
1.2 Requested by : MECO INSTRUMENTS PVT. LTD.
(Name and address of manufacturer) 301,BHARAT INDUSTRIAL
ESTATE,T.J.ROAD,SEWREE,MUMBAI-400 015

1.3 Item No.	Description	Qty	Manufacturer and Type No.	Serial No
1.	FREQUENCY TRNSDUCER	01	MECO INSTRUMENTS PVT. LTD./ FT	30946

1.4 Test specifications BS EN 61326 (Edition 1998)

1.5 Lab Ambient Temperature : (25 + 2) deg.C
Humidity : (55 + 5) % RH

- 1.6 Test Equipment used :
1. EMI/034 : RS Chamber (Keytek, G-Strip)
 2. EMI/036 : RF Signal Generator (HP, 8648 A) for C.S and R.S. tests
 3. EMI/037 : RF Amplifier (AR, 25A100) for R.S test
 4. EMI/044 : Three Phase Immunity Test System
 5. CPU/064 : EMI receiver (HP8568B) for CE and RE test
 6. EMI/048 : ESD Gun for ESD test
 7. ----- : Biconical & Log periodic antennae.
 8. EMI/033 : EFT Simulator
 9. EMI/034 : Coupling / De coupling Network
 10. CPU/066 : LISN



ELECTRONICS REGIONAL TEST LABORATORY (WEST) MINISTRY OF COMMUNICATIONS AND INFORMATION TECHNOLOGY (STQC DTE)	REPORT NO. ERTL(W)/ 2003EMI 263		
SUBJECT: EMC TESTING OF FREQUENCY TRANSDUCER	DATE 17 SEP 2003	PAGE 2	OF 9

2.0 EQUIPMENT UNDER TEST (EUT)

2.1 Description

EUT is an frequency transducer.

2.2 Operating modes during normal testing.

The output of EUT shall be loaded with full rated resistive load for normal operations & all applicable tests. The output current shall remain in the range of 0 to 10 mA DC at output 1 & in the range of 4 to 20 mA DC for output 2, during after & before all tests. EUT was made operational with rated input voltage & output was loaded with resistive load during immunity tests.

2.3 Functional check for all immunity tests.

The functional check for all immunity tests of EUT is to observe output current across the resistive load for O/P 1 & O/P 2.



ELECTRONICS REGIONAL TEST LABORATORY (WEST)		REPORT NO.	
MINISTRY OF COMMUNICATIONS AND INFORMATION TECHNOLOGY (STQC DTE)		ERTL(W)/ 2003EMI 263	
SUBJECT: EMC TESTING OF FREQUENCY TRANSDUCER		DATE	PAGE
		17 SEP 2003	3
			OF 9

3.0 Test Results

3.2 RADIATED EMISSION

Test Rationale: To measure emissions of the EUT radiated into space and to compare them with specified limits to ascertain that the EUT will not disturb other equipment by generating such emissions above a certain limit.

a) Test Condition:

Set-up As per BS EN 55022, CLASS 'A'
 Frequency Range 30 MHz – 1000MHz
 EUT in normal operating condition as per Sr. No. 2.2

b) Receiver:

Bandwidth 120 KHz
 Detectors QP
 Antenna Bi-Conical (For 30 – 200 MHz)
 Log-Periodic (For 200 – 1000 MHz)
 Configuration Conforming to CISPR 16-1 & CISPR 16-2

c) Test procedure

- Ambient measurements carried out first with EUT "off" and peaks noted
- EUT was switched "ON" and Emission peaks noted.
- Antenna height and position were changed to maximize Emissions.
- A table of Emission and corresponding Ambient was then drawn up.
- "Ambient" and "Emission" peaks were compared. Peaks with a difference of less than 5 dB were discarded.

d) Requirements

EUT emissions shall be below following limits

Freq. (MHz)	Limits (dBuV/m)
30-230	QP
230-1000	50
	57

e) Observations

For results pl. refer page 9 of 9.

f) Results

Complied



ELECTRONICS REGIONAL TEST LABORATORY (WEST) MINISTRY OF COMMUNICATIONS AND INFORMATION TECHNOLOGY (STQC DTE)	REPORT NO. ERTL(W)/ 2003EMI 263		
SUBJECT: EMC TESTING OF FREQUENCY TRANSDUCER	DATE 17 SEP 2003	PAGE 4	OF 9

3.3 RADIATED SUSCEPTIBILITY (RS)

Test Rationale: To check immunity characteristics of the EUT in the presence of radiated fields generated by intentional emitters like Radio /TV transmitters, wireless equipment and the like by illuminating the EUT by such frequency

- a) **Test Condition:**
 - Set-up As per BS EN 61000-4-3 (Edition – 1995)
 - Frequency Range 80 MHz – 1000 MHz
 - Field Strength 10 V/m
 - Simulation Using G – STRIP chamber
 - EUT in normal operating condition as per Sr. no. 2.2.

- b) **Test procedure**
EUT enclosure was exposed to radiated field strength in G strip chamber for the above subject frequency range. EUT performance was observed during and after the test as per Sr. No. 2.3

- c) **Requirements**
Normal performance of EUT shall be within the specifications as per Sr. No. 2.3.
Performance criterion A

- d) **Observations**
Operation normal as per Sr. No. 2.3 during and after the test. No deviation from actual operating condition could be observed.

- e) **Results**
Complied



ELECTRONICS REGIONAL TEST LABORATORY (WEST) MINISTRY OF COMMUNICATIONS AND INFORMATION TECHNOLOGY (STQC DTE)	REPORT NO. ERTL(W)/ 2003EMI 263		
	SUBJECT: EMC TESTING OF FREQUENCY TRANSDUCER	DATE 17 SEP 2003	PAGE 5

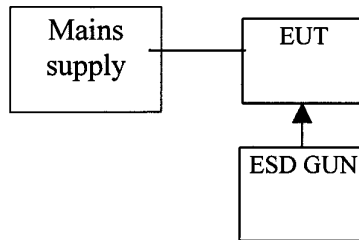
3.4 ELECTROSTATIC DISCHARGE (ESD)

Test Rationale: To check immunity characteristics of the EUT against Discharge of Static Electricity that may occur when a charged operator touches the EUT.

a) Test Condition:

Set-up As per BS EN 61000-4-2 (Edition 1995)
Mode of simulation: Contact Discharge on conductive surfaces &
Air Discharge on non- conductive surfaces
Test Voltage: **Contact Discharge:** 4kV
Air Discharge: 8kV
No. of Discharges 10
Polarity Positive and Negative
Points of Discharge **Contact Discharge**
Contact screws
Air Discharge:
On the Insulated surfaces
Simulation Using ESD Gun
EUT in normal operating condition as per Sr. no. 2.2.

b) Test procedure:



- EUT initially subjected to indirect discharge on VCP and HCP.
- EUT was then screened in continuous discharge mode.
- At susceptible points, ten single discharges were applied.

c) Requirement:

During testing, temporary degradation or loss of function or performance is allowed which is self-recoverable. Performance criterion B

d) Observations

Operation of the EUT was found normal during and after the test as per Sr. No. 2.3

e) Results
Complied



ELECTRONICS REGIONAL TEST LABORATORY (WEST)		REPORT NO.	
MINISTRY OF COMMUNICATIONS AND INFORMATION TECHNOLOGY (STQC DTE)		ERTL(W)/ 2003EMI 263	
SUBJECT: EMC TESTING OF FREQUENCY TRANSDUCER		DATE	PAGE
		17 SEP 2003	6
			OF 9

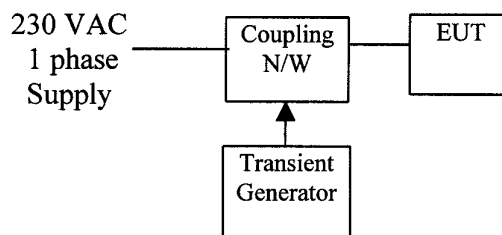
3.6 ELECTRICAL FAST TRANSIENTS (EFT)

Test Rationale: To check immunity characteristics of the EUT against transients generated by inductive load switching, Relay contact bouncing, switching of high voltage switchgear and the like

a Test Condition:

Set-up	As per BS EN 61000-4-4 (Edition 1995)
Pulse	5/50 ns
Modes	Common and Differential
Test Level	3
Pulse Amplitude	2kV
Pulse Rep. Rate	5 kHz
Polarity	Positive and Negative
Duration of test in each mode	60 s
Simulation	On 230 V single phase AC supply lines by Direct Injection
	EUT in normal operating condition as per Sr.No. 2.2

c Test procedure:



➤ Transients generated by the generator were coupled to the 230 VAC Supply through a coupling N/W .

d Requirements :

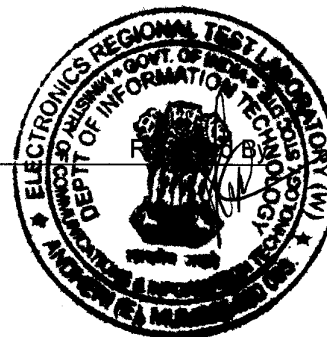
During testing, temporary degradation or loss of function or performance is allowed which is self-recoverable. Performance criterion B

e Observations

Operation of the EUT was found to be normal as per Sr. No. 2.3 during and after the test.

f Results

Complied



ELECTRONICS REGIONAL TEST LABORATORY (WEST) MINISTRY OF COMMUNICATIONS AND INFORMATION TECHNOLOGY (STQC DTE)	REPORT NO. ERTL(W)/ 2003EMI 263		
SUBJECT: EMC TESTING OF FREQUENCY TRANSDUCER	DATE	PAGE	OF
	17 SEP 2003	7	9

17 SEP 2003

3.3 Conducted susceptibility

Test Rationale:

To check immunity characteristics of the EUT against Conducted RF Susceptibility levels.

a) Test Condition:

Set-up As per BS EN 61000 – 4 –6 (Edition 1996)
Mode of simulation: Injected on power mains
Test Voltage: 3 V r.m.s

Simulation Using coupling/ decoupling Network
EUT in normal operating condition as per Sr.No. 2.2

c Test procedure:

➤ Conducted RF level was injected to power mains by coupling/ decoupling network along the subject frequency range & EUT performance was monitored during and after the test as per Sr.No. 2.3.

d Requirement:

Performance Criterion 'A', Normal Operation of the EUT with specified performance as per Sr.No. 2.3.

e Observations

Operation of the EUT was found normal during and after the test as per Sr.No. 2.3.

f Results

Complied

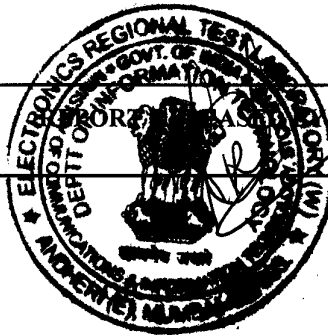


ELECTRONICS REGIONAL TEST LABORATORY (WEST) MINISTRY OF COMMUNICATIONS AND INFORMATION TECHNOLOGY (STQC DTE)	REPORT NO. ERTL(W)/ 2003EMI 263		
SUBJECT: EMC TESTING OF FREQUENCY TRANSDUCER	DATE 17 SEP 2003	PAGE 8	OF 9

4.0 General Remarks : Nil

REPORT APPROVED BY


 HEAD (EMI/PCT)



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ELECTRONICS REGIONAL TEST LABORATORY (WEST) MINISTRY OF COMMUNICATIONS AND INFORMATION TECHNOLOGY (STQC DTE)	REPORT NO. ERTL(W)/ 2003EMI 263		
SUBJECT: EMC TESTING OF FREQUENCY TRANSDUCER	DATE 17 SEP 2003	PAGE 9	OF 9

Radiated Emission Test Results

SR.NO.	FREQUENCY (MHz)	EMISSIONS OBSERVED (dBuV/m)	LIMITS (dBuV/m)	REMARKS
1.	30.63	26.10	50.00	Pass
2.	207.60	29.80	50.00	Pass
3.	214.80	33.00	50.00	Pass
4.	234.00	25.80	57.00	Pass

Testing has been carried out at 3- meter test distance and limits have been modified accordingly.



Released By

OUR ACCREDITATION STATUS

ERTL (W) set up under the STQC Directorate, Ministry of Communications & Information Technology, Govt. of India has been accredited under number of national / international systems as follows :

SYSTEM	AREA	STATUS
IECQ (International Electro-technical Commission on Quality Assessment System for Electronic Components)	Component Testing <ul style="list-style-type: none"> ● Resistors (Fixed) ● Capacitors (Fixed) 	Accredited as ITL (Independent Test Laboratory)
NABL (C), India National Accredital Board for Test & Calibration laboratories (Calibration System)	Calibration <ul style="list-style-type: none"> ● Electro-technical discipline ● Thermal discipline ● Mechanical discipline 	Accredited Calibration Laboratory
NABL(T), India National Accredital Board for Test & Calibration laboratories (Testing System)	Electronic & Electrical Testing	Accredited Test Laboratory
IECEE-CE-Scheme	<ul style="list-style-type: none"> ● Mains Operated Electronic Consumer Products 	Approved as a CB test Laboratory
Other recognition		Recognised by CSPO of State Govt., DOT, Naval Docyard, LCSO etc.